Se	arch	Notes	,
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Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/500,874		
Examiner	Art Unit	
Ibrahim A. Khan	2617	

SEARCHED			
Class	Subclass	Date	Examiner
455	432.1	3/3/2004	IAK
370	352	3/3/2004	IAK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
<u> </u>	DATE	EXMR
EASTImage and keyword search in USPAT, US-PGPUB, DERWENT, EPO, IBM_TDB (see attached search strategy)	3/3/2004	IAK
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